

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Divisional Patent Application of )  
Shunpei YAMAZAKI et al. )  
Based On Application No. 09/493,411 ) Art Unit: 2815  
Which Was Filed: January 28, 2000 ) Examiner: G. Eckert II  
For: SEMICONDUCTOR DEVICE AND )  
METHOD OF FABRICATING THE )  
SAME ) Date: June 26, 2003

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure as set forth in 37 C.F.R. §1.56, Applicants hereby submit the following information in conformance with 37 C.F.R. §§ 1.97 and 1.98. Pursuant to 37 C.F.R. § 1.98, a copy of each of the documents cited is enclosed.

The references listed on the attached Form PTO-1449 were cited in parent application Serial No. 09/493,411 filed January 28, 2000, from which priority is claimed under 35 U.S.C. 120.

It is requested that the accompanying PTO-1449 be considered and made of record in the above-identified application. To assist the Examiner, the documents are listed on the attached form PTO-1449. It is respectfully requested that an Examiner initialed copy of this form be returned to the undersigned.

Respectfully submitted,

By:

  
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Substitute for form 1449A/PTO				<b>Complete if Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>				Application Number	New Divisional Application
				Filing Date	June 26, 2003
				First Named Inventor	Shunpei YAMAZAKI et al.
				Art Unit	2815
				Examiner Name	G. Eckert, II
Sheet	1	of	2	Attorney Docket Number	740756-2626

U.S. PATENT DOCUMENTS					
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	U.S. Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number - Kind Code <sup>2</sup> (if known)			
		US-5,182,620	01/1993	Shimada et al.	
		US-5,739,549	04/1998	Takemura et al.	
		US-5,942,310	08/1999	Moon	
		US-6,067,132	05/2000	Kim	
		US-6,137,551	10/2000	Jeong	
		US-6,271,818	08/2001	Yamazaki et al.	
		US-6,490,014	12/2002	Ohtani et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)				
		GB 2-307 326	05/1997	Shin et al.		

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
		Shimokawa et al., "Characterization of High-Efficiency Cast-Si Solar Cell Wafers by MBIC Measurement", Japanese Journal of Applied Physics, Vol. 27, No. 5, May, 1988, pp. 751-758.	

Examiner Signature		Date Considered	
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

<b>Form PTO-1449</b> (Rev. 8-83)	U.S. Department of Commerce Patent and Trademark Office	Attorney Docket: 740756-2626	Serial No.			
<b>INFORMATION DISCLOSURE STATEMENT</b> (Use several sheets if necessary)						
		Applicant: Shunpei YAMAZAKI et al.				
		Filing Date: June 26, 2003	Group: 2815			
<b>U.S. PATENT DOCUMENTS</b>						
Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
	5,643,826	07/01/1997	Ohtani et al.			
	5,923,962	07/13/1999	Ohtani et al.			
	5,895,933	04/20/1999	Zhang et al.			
	5,882,960	03/16/1999	Zhang et al.			
	5,608,251	03/04/1997	Konuma et al.			
	5,620,905	04/15/1997	Konuma et al.			
	5,712,495	01/27/1998	Suzawa			
	5,856,689	01/05/1999	Suzawa			
	5,998,841	12/07/1999	Suzawa			
	4,409,724	10/18/1983	Tasch et al.			
	4,823,180	04/18/1989	Wieder et al.			
	4,851,370	07/25/1989	Doklan et al.			
	4,886,962	12/12/1989	Gofuku et al.			
	5,292,675	03/08/1994	Codama			
	5,343,066	08/30/1994	Okamoto et al.			
	5,365,079	11/15/1994	Kodaira et al.			
	5,616,935	04/01/1997	Koyama et al.			
	5,508,209	04/16/1996	Zhang et al.			
<b>FOREIGN PATENT DOCUMENTS</b>						
	Document Number	Date	Country	Class	Subclass	<u>Translation</u>
	07-130652	05/19/1995	Japan			Abstract
	07-321339	12/08/1995	Japan			Abstract
	09-312260	12/02/1997	Japan			Abstract
	10-056184	02/24/1998	Japan			Abstract
	10-247735	09/14/1998	Japan			Abstract
	07-130974	05/19/1995	Japan			Abstract
	07-135323	05/23/1995	Japan			Abstract
	07-169974	07/04/1995	Japan			Abstract
	07-169975	07/04/1995	Japan			Abstract
	07-218932	08/18/1995	Japan			Abstract
Examiner			Date Considered			
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						